

Table 2. Selected geometric parameters (Å. °)

Symmetry codes: (i) $x - 1$, y, z; (ii) $1 - x$, $-y$, $-z$; (iii) $-x$, $y - \frac{1}{2}$, $\frac{1}{2} - z$; (iv) $x, \frac{1}{2} - y, z - \frac{1}{2}$; (v) $-x, -y, 1 - z$; (vi) $1 - x, \frac{1}{2} + y, \frac{3}{2} - z$; (vii) $x, \frac{1}{2} - y, \frac{1}{2} + z$; (viii) $1 - x, -y, 1 - z$; (ix) $1 + x, y, z$; (x) $x, y, 1 + z$.

A clear, colorless, plate-shaped crystal was mounted on a glass fiber with epoxy for X-ray structure analysis. Data were collected with a scan speed of 16.0° min⁻¹ in ω and a scan width of $(1.5 + 0.3\tan\theta)$ °.

The TEXSAN crystallographic software package (Molecular Structure Corporation, 1989) was used to solve the crystal structure. The Laue symmetry *2/m* and the systematic absences *hOl* $(l = 2n + 1)$ and $0k0$ $(k = 2n + 1)$ unambiguously indicated space group $P2₁/c$. The positions of the Cs atoms were determined by a Patterson vector map and the remaining atoms were found by examination of the difference electron density maps. After isotropic refinement, the data were averaged and corrected for absorption.

Lists of structure factors, anisotropic displacement parameters and complete geometry have been deposited with the IUCr (Reference: BR1078). Copies may be obtained through The Managing Editor, International Union of Crystallography, 5 Abbey Square, Chester CH1 2HU, England.

References

Heller, G. (1986). *Topics Curr. Chem.* 131, 39-98.

Molecular Structure Corporation (1989). *TEXSAN. TEXRAY Structure Analysis Package.* MSC, 3200 Research Forest Drive, The Woodlands, TX 77381, USA.

Acta Cryst. (1995). C51, 549-551

Neodymium-Doped Srs(PO4)aF and Srs(VO4)aF

DEBORAH L. CORKER

Clarendon Laboratory, University of Oxford, Parks Road, Oxford OX1 3PU, England

BRUCE H. T. CHAI, JOHN NICHOLLS AND GEORGE B. Lotrrrs

CREOL, University of Central Florida, 12424 Research Parkway, Orlando, USA

(Received 22 *February* 1994; *accepted 15 June* 1994)

Abstract

Neodymium-doped $Sr₅(PO₄)₃F$ [neodymium strontium fluoride phosphate, $(Nd, Sr)_{5}(PO_{4})_{3}F1$ and neodymiumdoped $Sr₅(VO₄)₃F$ [neodymium strontium fluoride vanadate, $(Nd, Sr)_{5}(VO_{4})_{3}F$] crystallize in space group *P63/m* and are isostructural with calcium fluorophosphate, $Ca₅(PO₄)₃F$. There are two different Sr sites in $Sr₅(XO₄)₃F$, denoted $Sr(1)$ and $Sr(2)$. Using singlecrystal X-ray diffraction the two structures were refined to R factors of 2.3 and 2.2%, respectively, showing that Nd is present at both Sr sites in $(Sr, Nd)_{5}(VO_{4})_{3}F$ but only at the Sr(2) site in $(Sr, Nd)_5 (PO_4)_3F$.

Comment

Calcium fluorophosphate (FAP) crystals have been investigated previously as laser hosts, and lasing characteristics of rare-earth-doped FAP were reported as early as 1968 (Ohlmann, Steinbruegge & Mazelsky, 1968). Recent developments have reopened investigations into FAP and the whole calcium-strontium fluorophosphate system for use as laser hosts. This paper presents the detailed crystal structure refinements that followed the recent successful crystal growth of neodymium-doped $Sr₅(PO₄)₃F$ (SFAP) and neodymium-doped $Sr₅(VO₄)₃F$ (SVAP).

Both crystals were grown by the Czochralski method. SVAP and SFAP are isostructural and belong to the hexagonal space group *P63/m. The* structure contains layers of XO_4 tetrahedra $(X = P, V)$ centred at two levels along [001] and F^- ions lying along the c axis, as can be seen in Fig. 1. V- \sim O and P \sim O bond lengths are given in Tables 2 and 4, respectively, and show that the VO4 tetrahedra are distorted [average/(deviation) for P- $-$ O and V- $-$ O bond distances are 1.541 $\rm \AA/(0.004\,\AA)$ and 1.711 $\rm \AA/(0.01\AA)$, respectively].

There are two independent Sr sites in the structures, the first of which, $Sr(1)$, contains 40% of the Sr^{2+}

Shannon, R. D. (1976). *Acta Cryst.* A32, 751-767.

Walker, N. & Stuart, D. (1983). *Acta Cryst.* A39, 158-166.

ions when fully occupied and has threefold symmetry. The remaining 60% of the Sr²⁺ ions are found at the Sr(2) sites, which have reflection symmetry in the plane perpendicular to the c axis. Each Sr(2) site has an $F^$ ion as its nearest neighbour. Nd substitutes for Sr in both SVAP and SFAP, but the location of the dopant in the two compounds is different to within the precision of the X-ray structure refinement. Nd^{3+} was found to be present on the Sr(2) site in both SVAP and SFAP, but only in SVAP was Nd^{3+} present on the Sr(1) site as well.

A charge-compensation mechanism is required for the 1:1 substitution of Nd^{3+} for Sr^{2+} . This has been discussed previously by Mackie & Young (1973) for the similar structure of neodymium-doped FAP, where the substitution of Q^{2-} for F^- and the creation of $Ca²⁺$ (in this case $Sr²⁺$) vacancies were considered. For this reason, all site occupancies in the present work were refined. In both SVAP and SFAP all the Osite occupancies converged to a value slightly greater than unity, and so were fixed at unity for the final cycles of refinement. Likewise, the occupancy of the F sites refined to a value greater than or within experimental error of unity. However, a reduction in the site occupancy factors for the V and P sites in SVAP and SFAP, respectively, was observed, which could be the mechanism for charge balance in these compounds,

Further evidence supporting the location of the Nd dopant was obtained by investigation of the absorption and fluorescence spectra of Nd in SVAP and SFAP. This work, carried out at CREOL, suggested that essentially all the Nd in SFAP is on the Sr(2) site, while Nd was

Fig. 1. The structure of $Sr₅(PO₄)₃F$ projected along [001] and then rotated 6° around the y axis, showing the two Sr sites and the PO₄ tetrahedra.

seen on both Sr sites in SVAP. However, the results indicated a preference for the Sr(2) site which could not be seen from the X-ray analysis. The preference for substitution at the Sr(2) site, which is smaller than the Sr(1) site, can be explained by the fact that the ionic radius of Nd^{3+} is much smaller than that of Sr^{2+} .

reflections
 $\theta = 18 - 20^{\circ}$

Blue

 $R_{\text{int}} = 0.078$ $\theta_{\text{max}} = 32.5^{\circ}$ $h = -13 \rightarrow 13$ $k = -15 \rightarrow 15$ $l = -11 \rightarrow 11$ 3 standard reflections frequency: 60 min intensity decay: 1.5%

Room temperature

Experimental SVAP

Crystal data

 $(Kr_{0.982}Nd_{0.012})_5(VO_4)_3F$ Mo $K\alpha$ radiation
 $M_r = 798.02$ $\lambda = 0.71069 \text{ Å}$ $M_r = 798.02$ $\lambda = 0.71069$ Å
Hexagonal Cell parameters Hexagonal Cell parameters from 36
 $P6_3/m$ reflections $a = 10.0077$ (6) Å
c = 7.4342 (8) Å $c = 7.4342 \text{ (8)} \text{ Å}$ $\mu = 23.66 \text{ mm}^{-1}$
 $V = 644.82 \text{ Å}^3$ Room temperature $Z = 2$ Irregular $D_x = 4.11 \text{ Mg m}^{-3}$ 0.15 × 0.11 × 0.07 mm

Data collection

Stoe Stadi-4 diffractometer ω -2 θ scans Absorption correction: ψ scans of five reflections $T_{\text{min}} = 0.0825$, $T_{\text{max}} =$ 0.1860 3146 measured reflections 831 independent reflections

421 observed reflections

 $[I > 3\sigma(I)]$

Refinement

Table 1. *Fractional atomic coordinates and equivalent isotropic displacement parameters* (A^2) for SVAP

 $U_{eq} = (1/3)\sum_{i}\sum_{j}U_{ij}a_{i}^{*}a_{j}^{*}a_{i}...a_{j}$.

Symmetry codes: (i) $y - x$, $1 - x$, $\frac{1}{2} - z$; (ii) $1 - y$, $1 + x - y$, $\frac{1}{2} - z$; (iii) $x-y, x, -z$; (iv) y, $1+y-x, -z$; (v) $1-x, 1-y, -z$; (vi) y, $-x+y, \frac{1}{2}+z$; (vii) $y, y-x, -z$; (viii) $1-y, -y+x, z$; (ix) $x, y, \frac{1}{2}-z$; (x) $-x+y, -x, z$; (xi) $y - x, -x, \frac{1}{2} - z$.

> Mo $K\alpha$ radiation $\lambda = 0.71069$ Å

reflections $\theta = 17 - 19^{\circ}$ $\mu = 23.73$ mm⁻¹ Room temperature

Irregular

Blue-purple

 $R_{\text{int}} = 0.075$ $\theta_{\text{max}} = 35^{\circ}$ $h = -13 \rightarrow 13$ $k = -15 \rightarrow 15$ $l = -11 \rightarrow 11$ 3 standard reflections frequency: 60 min intensity decay: 1%

Cell parameters from 46

 $0.14 \times 0.10 \times 0.06$ mm

SFAP

Crystal data

Data collection

Stoe Stadi-4 diffractometer ω -2 θ scans Absorption correction: ψ scans of five reflections $T_{\text{min}} = 0.0817$, $T_{\text{max}} =$ 0.2043 3682 measured reflections 942 independent reflections 460 observed reflections $[I > 3\sigma(I)]$

Refinement

Table 3. *Fractional atomic coordinates and equivalent isotropic displacement parameters* (\AA ²) for SFAP

$U_{eq} = (1/3)\sum_i \sum_j U_{ij} a_i^* a_i^* a_i^* a_j^*.$

Table 4. *Selected geometric parameters* (A) for **SFAP**

Symmetry codes: (i) $y - x$, $1 - x$, $\frac{1}{2} - z$; (ii) $1 - y$, $1 + x - y$, $\frac{1}{2} - z$; (iii) $x-y, x, -z$; *(iv)* $y, 1 + y-x, -z$; *(v)* $1-x, 1-y, -z$; *(vi)* $y, -x+y, \frac{1}{2} +z$; (vii) y, y - x, -z; (viii) -x + y, -x, z; (ix) x, y, $\frac{1}{2}$ - z; (x) 1 - y, -y + x, z; (xi) $y - x, -x, \frac{1}{2} - z$.

Data were collected using a leamt-profile method (Clegg, 1981). Data collection and reduction were performed using *DIF4* (Stoe & Cie, 1988a) and *REDU4* (Stoe & Cie, 1988b). Cell constants were refined using high 2θ reflections extracted from the data collection and measured with double stepscans. Refinement of both structures was carried out using *CRYSTALS* (Watkin, Carruthers & Betteridge, 1985). The atomic coordinates for $Ca₅(PO₄)₃F$ (Mackie & Young, 1973) were used as an initial model for both refinements. The positional and displacement parameters for Nd rode with the corresponding Sr parameters. Their occupancies were refined separately so that a vacancy on an Sr site would not give rise to an increase in Nd occupancy.

DLC wishes to thank Dr A. M. Glazer for producing the diagram of $Sr₅(PO₄)₃F$ shown in this paper and also wishes to express gratitude to the Science and Engineering Research Council for a studentship.

Lists of structure factors and anisotropic displacement parameters have been deposited with the IUCr (Reference: DU1084). Copies may be obtained through The Managing Editor, International Union of Crystallography, 5 Abbey Square, Chester CH1 2HU, England.

References

Clegg, w. (1981). *Acta Cryst.* A37, 22-28.

- Larson, A. C. (1970). *Crystallographic Computing,* edited by F. R. Ahmed, S. R. Hall & C. P. Huber, pp. 291-294. Copenhagen: Munksgaard.
- Mackie, P. E. & Young, R. A. (1973). *J. Appl. Cryst.* 6, 26-31.
- Ohlmann, R. C., Steinbruegge, K. B. & Mazelsky, R. (1968). *Appl. Opt.* 7, 905-914.
- Stoe & Cie (1988a). *DIF4. Diffractometer Control Program.* Version 6.2. Stoe & Cie, Darmstadt, Germany.
- Stoe & Cie (1988b). *REDU4. Data Reduction Program.* Version 6.2. Stoe & Cie, Darmstadt, Germany.
- Watkin, D. J., Carruthers, J. R. & Betteridge, P. W. (1985). *CRYSTALS User Guide.* Chemical Crystallography Laboratory, Univ. of Oxford, England.